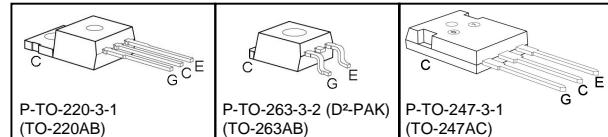
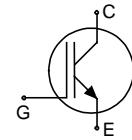


### Fast IGBT in NPT-technology

- 40% lower  $E_{\text{off}}$  compared to previous generation
- Short circuit withstand time – 10  $\mu\text{s}$
- Designed for:
  - Motor controls
  - Inverter
  - SMPS
- NPT-Technology offers:
  - very tight parameter distribution
  - high ruggedness, temperature stable behaviour
  - parallel switching capability



- Complete product spectrum and PSpice Models : <http://www.infineon.com/igbt/>

| Type      | $V_{\text{CE}}$ | $I_{\text{C}}$ | $E_{\text{off}}$ | $T_j$ | Package         | Ordering Code |
|-----------|-----------------|----------------|------------------|-------|-----------------|---------------|
| SGP15N120 | 1200V           | 15A            | 1.5mJ            | 150°C | TO-220AB        | Q67040-S4274  |
| SGB15N120 |                 |                |                  |       | TO-263AB(D2PAK) | Q67040-S4275  |
| SGW15N120 |                 |                |                  |       | TO-247AC        | Q67040-S4276  |

### Maximum Ratings

| Parameter   | Symbol                | Value      | Unit             |
|---|-----------------------|------------|------------------|
| Collector-emitter voltage   | $V_{\text{CE}}$       | 1200       | V                |
| DC collector current  | $I_{\text{C}}$        |            | A                |
| $T_C = 25^\circ\text{C}$  |                       | 30         |                  |
| $T_C = 100^\circ\text{C}$   |                       | 15         |                  |
| Pulsed collector current, $t_p$ limited by $T_{j\text{max}}$  | $I_{\text{Cpuls}}$    | 52         |                  |
| Turn off safe operating area  | -                     | 52         |                  |
| $V_{\text{CE}} \leq 1200\text{V}, T_j \leq 150^\circ\text{C}$   |                       |            |                  |
| Gate-emitter voltage  | $V_{\text{GE}}$       | $\pm 20$   | V                |
| Avalanche energy, single pulse  | $E_{\text{AS}}$       | 85         | mJ               |
| $I_{\text{C}} = 15\text{A}, V_{\text{CC}} = 50\text{V}, R_{\text{GE}} = 25\Omega$ , start at $T_j = 25^\circ\text{C}$ |                       |            |                  |
| Short circuit withstand time <sup>1)</sup>  | $t_{\text{SC}}$       | 10         | $\mu\text{s}$    |
| $V_{\text{GE}} = 15\text{V}, 100\text{V} \leq V_{\text{CC}} \leq 1200\text{V}, T_j \leq 150^\circ\text{C}$            |                       |            |                  |
| Power dissipation   | $P_{\text{tot}}$      | 198        | W                |
| $T_C = 25^\circ\text{C}$  |                       |            |                  |
| Operating junction and storage temperature  | $T_j, T_{\text{stg}}$ | -55...+150 | $^\circ\text{C}$ |
| Soldering temperature, 1.6mm (0.063 in.) from case for 10s  | -                     | 260        |                  |

<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



SGP15N120

SGP15N120

SGW15N120

### Thermal Resistance

| Parameter                                | Symbol     | Conditions           | Max. Value | Unit |
|--|------------|----------------------|------------|------|
| <b>Characteristic</b>                    |            |                      |            |      |
| IGBT thermal resistance, junction – case | $R_{thJC}$ |                      | 0.63       | K/W  |
| Thermal resistance, junction – ambient   | $R_{thJA}$ | TO-220AB<br>TO-247AC | 62<br>40   |      |
| SMD version, device on PCB <sup>1)</sup> | $R_{thJA}$ | TO-263AB(D2PAK)      | 40         |      |

**Electrical Characteristic**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Conditions | Value |      |      | Unit |
|-----------|--------|------------|-------|------|------|------|
|           |        |            | min.  | typ. | max. |      |

### Static Characteristic

|                                      |                      |   |          |            |            |               |
|--------------------------------------|----------------------|---|----------|------------|------------|---------------|
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$        | $V_{GE}=0\text{V}$ ,<br>$I_C=1000\mu\text{A}$   | 1200     | -          | -          | V             |
| Collector-emitter saturation voltage | $V_{CE(\text{sat})}$ | $V_{GE} = 15\text{V}$ , $I_C=15\text{A}$<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$   | 2.5<br>- | 3.1<br>3.7 | 3.6<br>4.3 |               |
| Gate-emitter threshold voltage       | $V_{GE(\text{th})}$  | $I_C=600\mu\text{A}$ , $V_{CE}=V_{GE}$  | 3        | 4          | 5          |               |
| Zero gate voltage collector current  | $I_{CES}$            | $V_{CE}=1200\text{V}$ , $V_{GE}=0\text{V}$<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$ | -<br>-   | -          | 200<br>800 | $\mu\text{A}$ |
| Gate-emitter leakage current         | $I_{GES}$            | $V_{CE}=0\text{V}$ , $V_{GE}=20\text{V}$  | -        | -          | 100        | nA            |
| Transconductance                     | $g_{fs}$             | $V_{CE}=20\text{V}$ , $I_C=15\text{A}$  |          | 11         | -          | S             |

### Dynamic Characteristic

|  |                   |  |   |         |      |    |
|--|-------------------|--|---|---------|------|----|
| Input capacitance  | $C_{iss}$         | $V_{CE}=25\text{V}$ ,<br>$V_{GE}=0\text{V}$ ,<br>$f=1\text{MHz}$   | - | 1250    | 1500 | pF |
| Output capacitance   | $C_{oss}$         |  | - | 100     | 120  |    |
| Reverse transfer capacitance                                   | $C_{rss}$         |  | - | 65      | 80   |    |
| Gate charge  | $Q_{\text{Gate}}$ | $V_{CC}=960\text{V}$ , $I_C=15\text{A}$<br>$V_{GE}=15\text{V}$   | - | 130     | 175  | nC |
| Internal emitter inductance measured 5mm (0.197 in.) from case | $L_E$             | TO-220AB<br>TO-247AC   | - | 7<br>13 | -    | nH |
| Short circuit collector current <sup>2)</sup>                  | $I_{C(SC)}$       | $V_{GE}=15\text{V}$ , $t_{SC}\leq 5\mu\text{s}$<br>$100\text{V}\leq V_{CC}\leq 1200\text{V}$ ,<br>$T_j \leq 150^\circ\text{C}$ | - | 145     | -    | A  |

<sup>1)</sup> Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70μm thick) copper area for collector connection. PCB is vertical without blown air.

<sup>2)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



SGP15N120

SGP15N120

SGW15N120

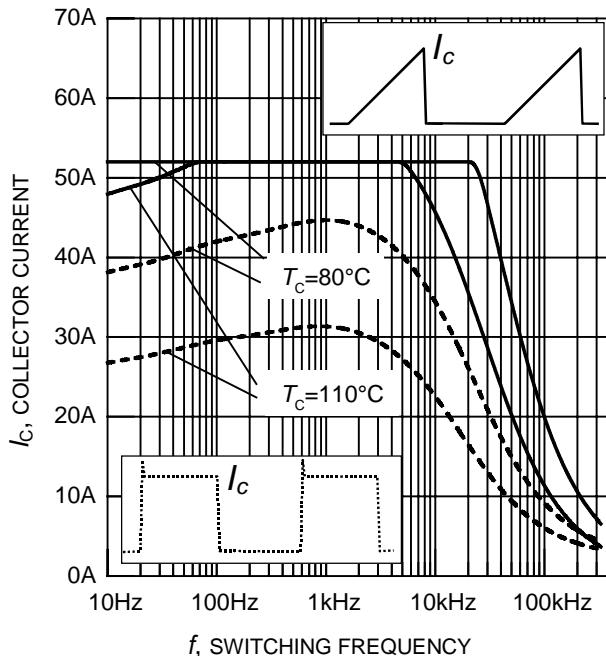
**Switching Characteristic, Inductive Load, at  $T_j=25^\circ\text{C}$**

| Parameter                  | Symbol       | Conditions  | Value |      |      | Unit |
|----------------------------|--------------|---|-------|------|------|------|
|                            |              |   | min.  | typ. | max. |      |
| <b>IGBT Characteristic</b> |              |   |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=25^\circ\text{C}$ ,<br>$V_{CC}=800\text{V}$ , $I_C=15\text{A}$ ,<br>$V_{GE}=15\text{V}/0\text{V}$ ,<br>$R_G=33\Omega$ ,<br>$L_\sigma^{(1)}=180\text{nH}$ ,<br>$C_\sigma^{(1)}=40\text{pF}$<br>Energy losses include<br>"tail" and diode<br>reverse recovery. | -     | 18   | 24   | ns   |
| Rise time                  | $t_r$        |   | -     | 23   | 30   |      |
| Turn-off delay time        | $t_{d(off)}$ |   | -     | 580  | 750  |      |
| Fall time                  | $t_f$        |   | -     | 22   | 29   |      |
| Turn-on energy             | $E_{on}$     |   | -     | 1.1  | 1.5  | mJ   |
| Turn-off energy            | $E_{off}$    |   | -     | 0.8  | 1.1  |      |
| Total switching energy     | $E_{ts}$     |   | -     | 1.9  | 2.6  |      |

**Switching Characteristic, Inductive Load, at  $T_j=150^\circ\text{C}$**

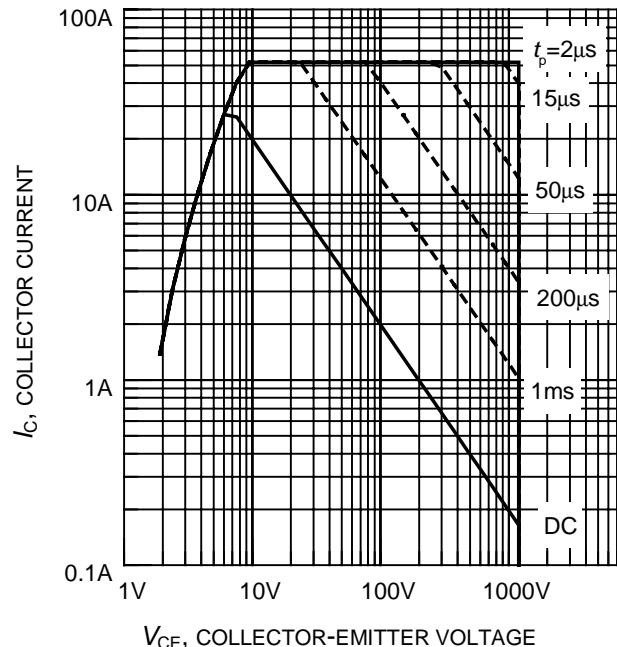
| Parameter                  | Symbol       | Conditions  | Value |      |      | Unit |
|----------------------------|--------------|---|-------|------|------|------|
|                            |              |   | min.  | typ. | max. |      |
| <b>IGBT Characteristic</b> |              |   |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=150^\circ\text{C}$ ,<br>$V_{CC}=800\text{V}$ ,<br>$I_C=15\text{A}$ ,<br>$V_{GE}=15\text{V}/0\text{V}$ ,<br>$R_G=33\Omega$ ,<br>$L_\sigma^{(1)}=180\text{nH}$ ,<br>$C_\sigma^{(1)}=40\text{pF}$<br>Energy losses include<br>"tail" and diode<br>reverse recovery. | -     | 38   | 46   | ns   |
| Rise time                  | $t_r$        |   | -     | 30   | 36   |      |
| Turn-off delay time        | $t_{d(off)}$ |   | -     | 652  | 780  |      |
| Fall time                  | $t_f$        |   | -     | 31   | 37   |      |
| Turn-on energy             | $E_{on}$     |   | -     | 1.9  | 2.3  | mJ   |
| Turn-off energy            | $E_{off}$    |   | -     | 1.5  | 2.0  |      |
| Total switching energy     | $E_{ts}$     |   | -     | 3.4  | 4.3  |      |

<sup>1)</sup> Leakage inductance  $L_\sigma$  and stray capacity  $C_\sigma$  due to dynamic test circuit in figure E.



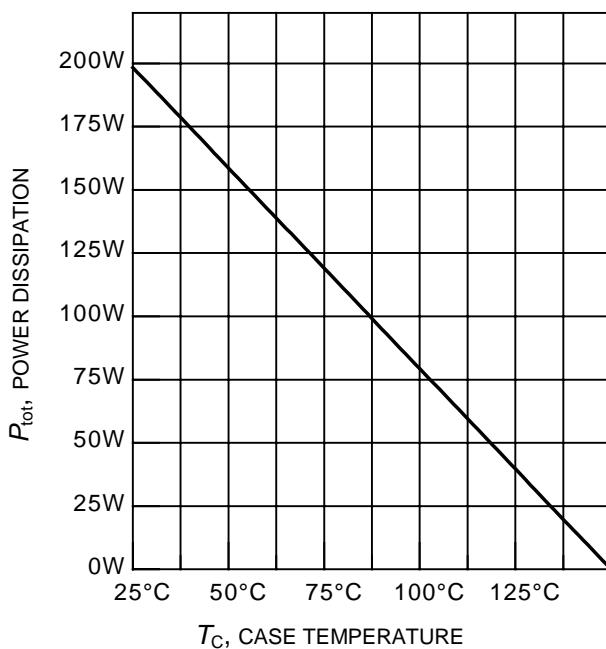
**Figure 1. Collector current as a function of switching frequency**

( $T_j \leq 150^\circ\text{C}$ ,  $D = 0.5$ ,  $V_{CE} = 800\text{V}$ ,  
 $V_{GE} = +15\text{V}/0\text{V}$ ,  $R_G = 33\Omega$ )



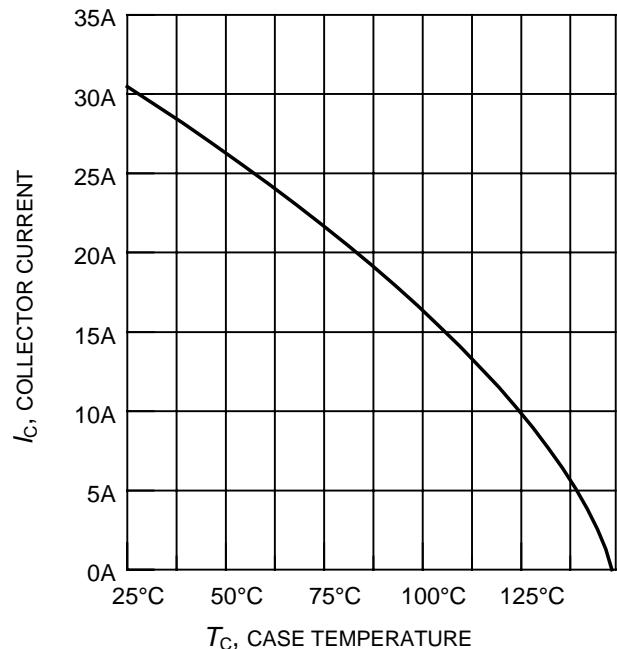
**Figure 2. Safe operating area**

( $D = 0$ ,  $T_C = 25^\circ\text{C}$ ,  $T_j \leq 150^\circ\text{C}$ )



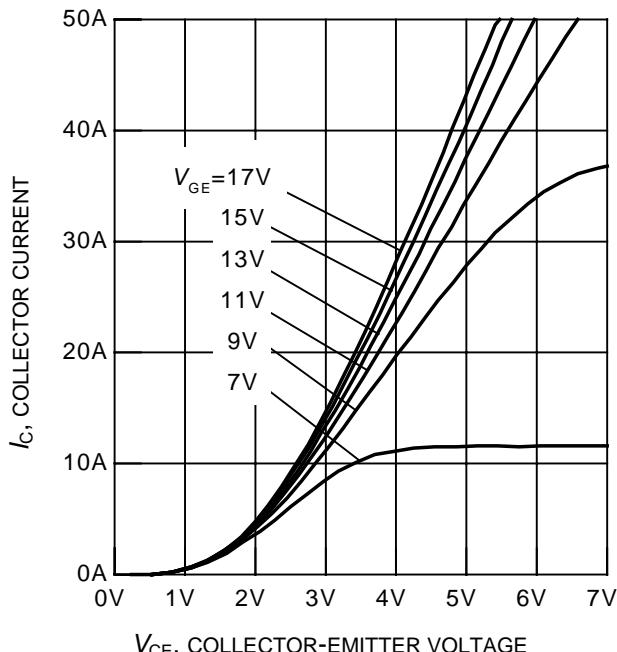
**Figure 3. Power dissipation as a function of case temperature**

( $T_j \leq 150^\circ\text{C}$ )

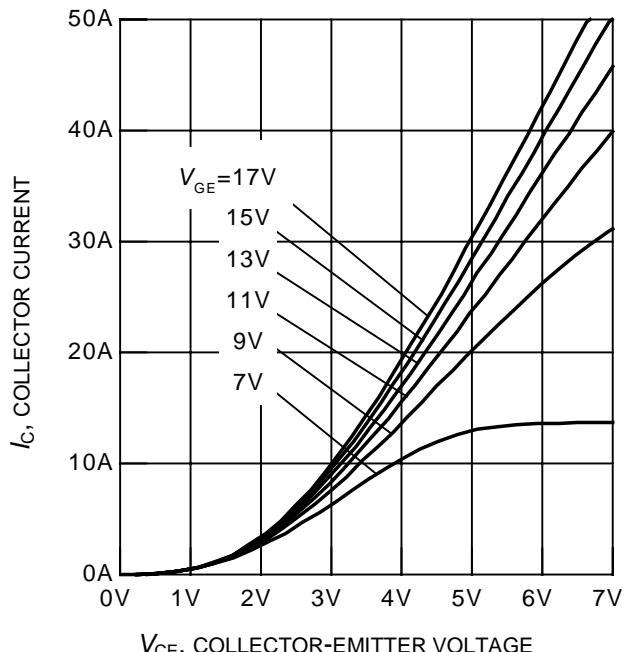


**Figure 4. Collector current as a function of case temperature**

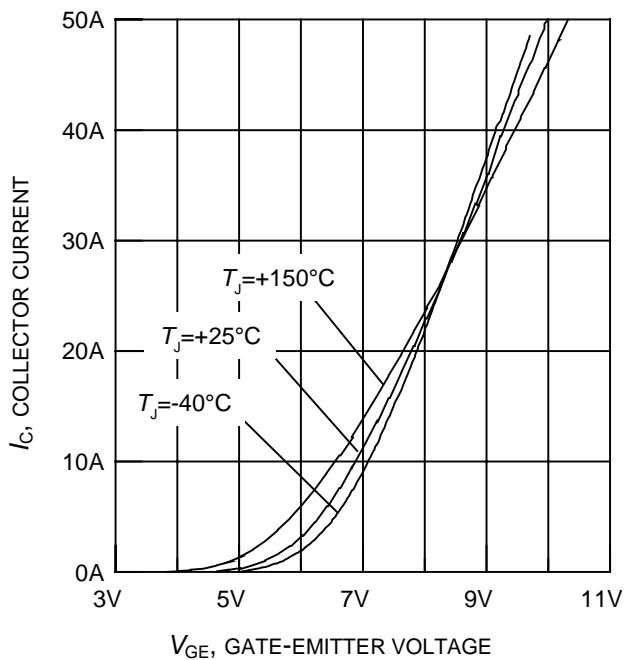
( $V_{GE} \leq 15\text{V}$ ,  $T_j \leq 150^\circ\text{C}$ )



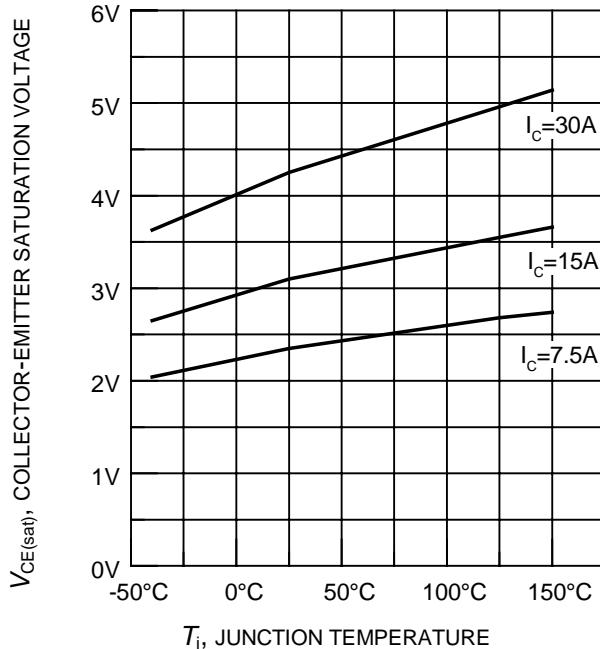
**Figure 5. Typical output characteristics**  
 $(T_j = 25^\circ\text{C})$



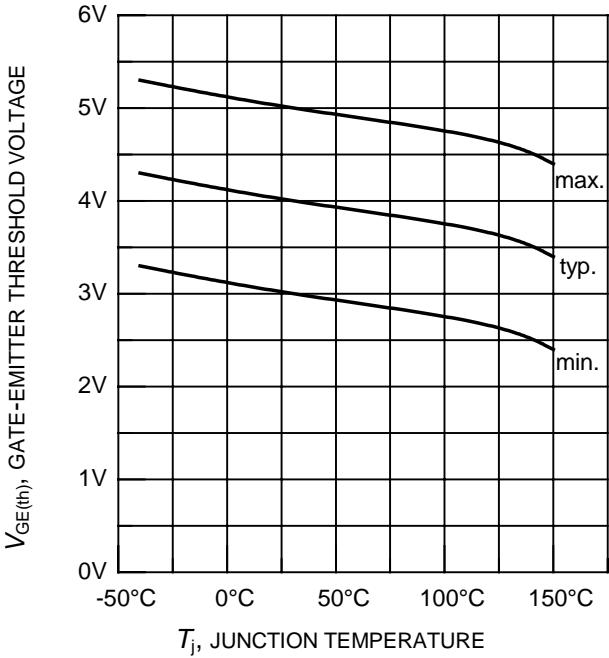
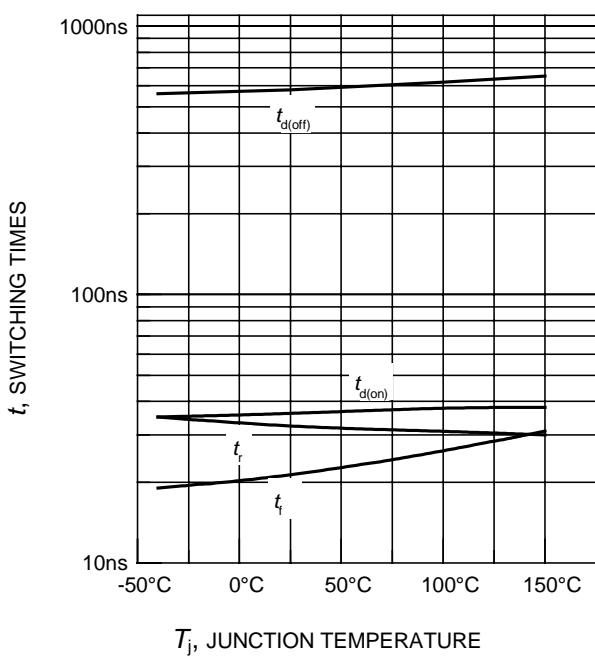
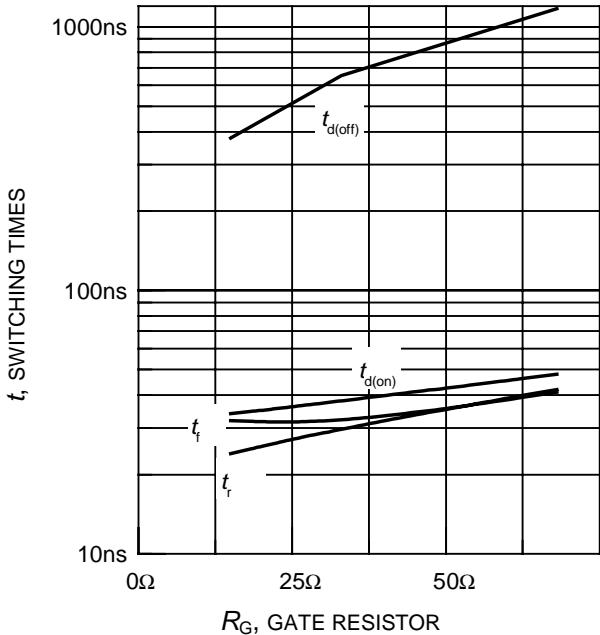
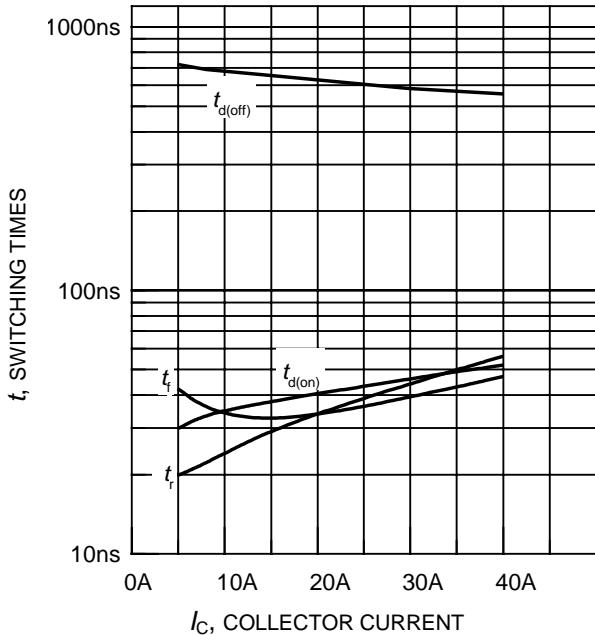
**Figure 6. Typical output characteristics**  
 $(T_j = 150^\circ\text{C})$

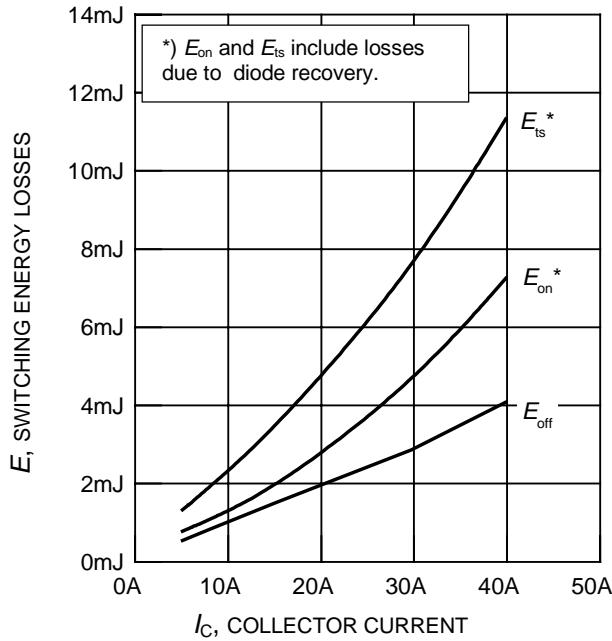


**Figure 7. Typical transfer characteristics**  
 $(V_{CE} = 20\text{V})$



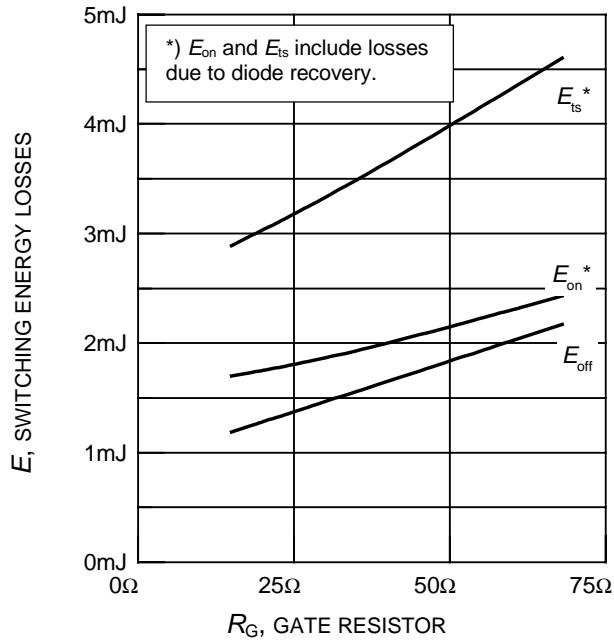
**Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature**  
 $(V_{GE} = 15\text{V})$





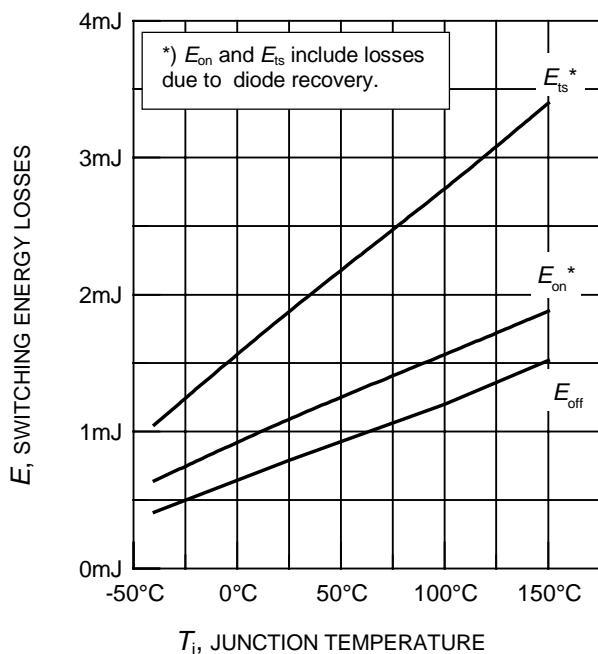
**Figure 13. Typical switching energy losses as a function of collector current**

(inductive load,  $T_j = 150^\circ\text{C}$ ,  
 $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $R_G = 33\Omega$ ,  
dynamic test circuit in Fig.E )



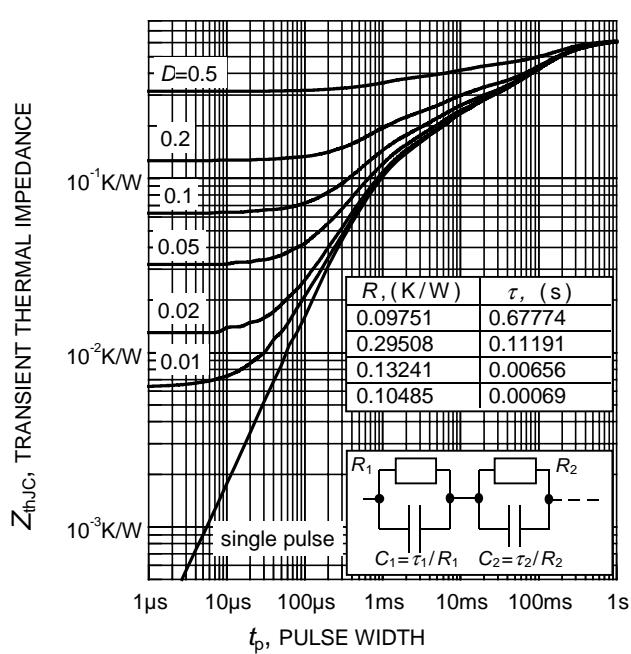
**Figure 14. Typical switching energy losses as a function of gate resistor**

(inductive load,  $T_j = 150^\circ\text{C}$ ,  
 $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 15\text{A}$ ,  
dynamic test circuit in Fig.E )

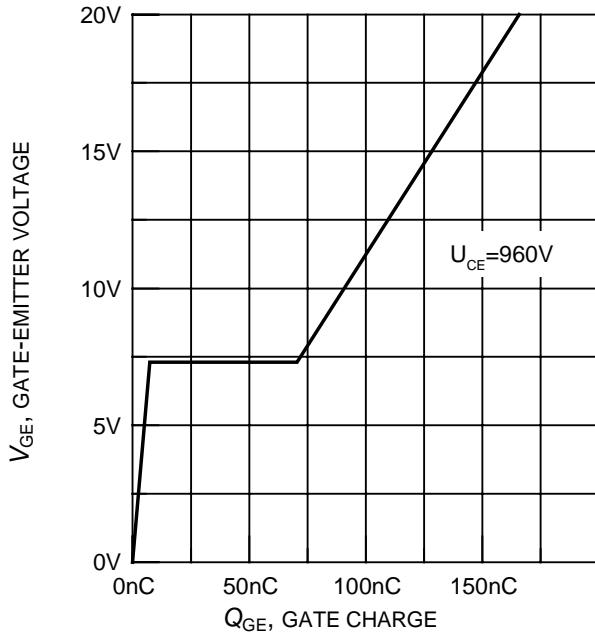


**Figure 15. Typical switching energy losses as a function of junction temperature**

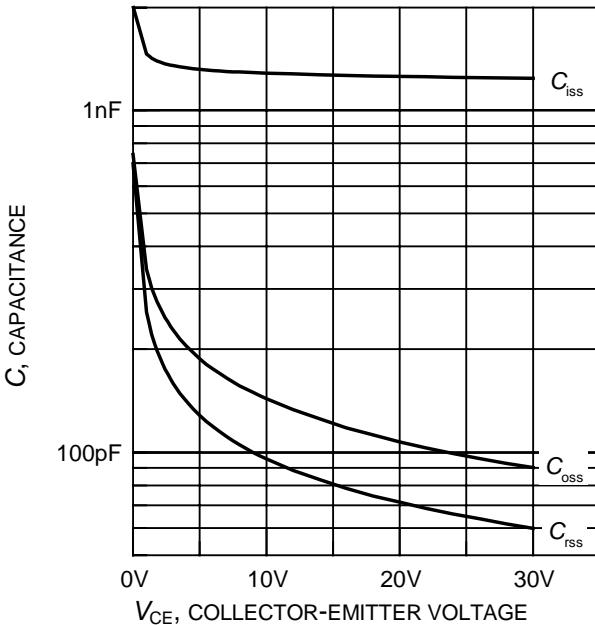
(inductive load,  $V_{CE} = 800\text{V}$ ,  
 $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 15\text{A}$ ,  $R_G = 33\Omega$ ,  
dynamic test circuit in Fig.E )



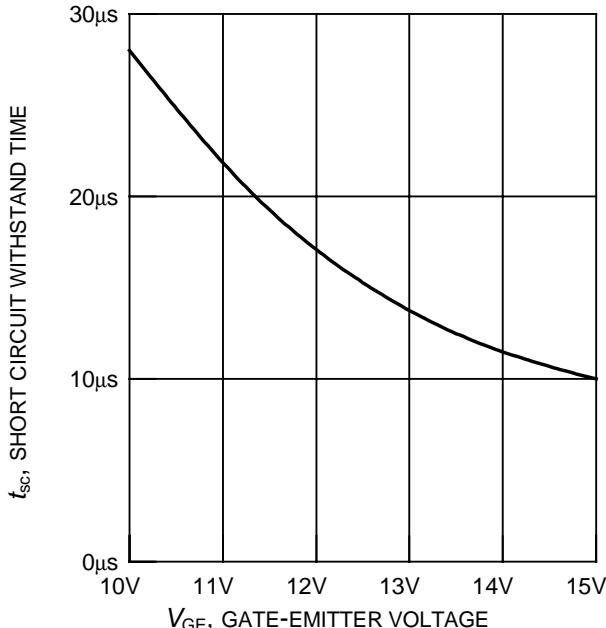
**Figure 16. IGBT transient thermal impedance as a function of pulse width**



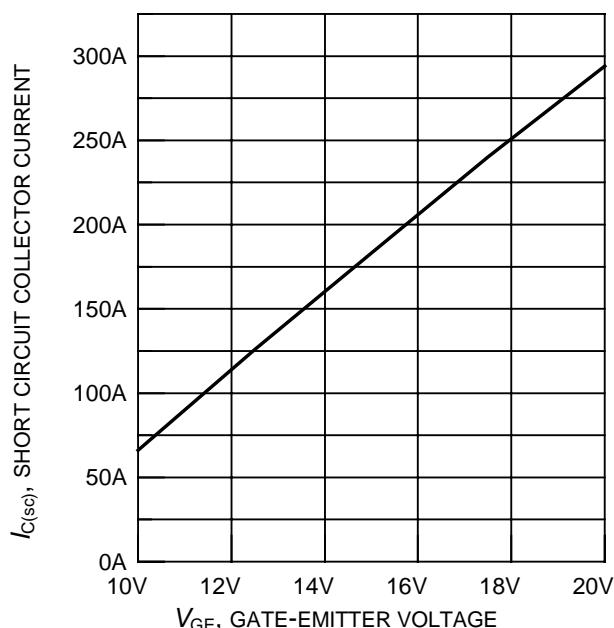
**Figure 17. Typical gate charge**  
( $I_C = 15A$ )



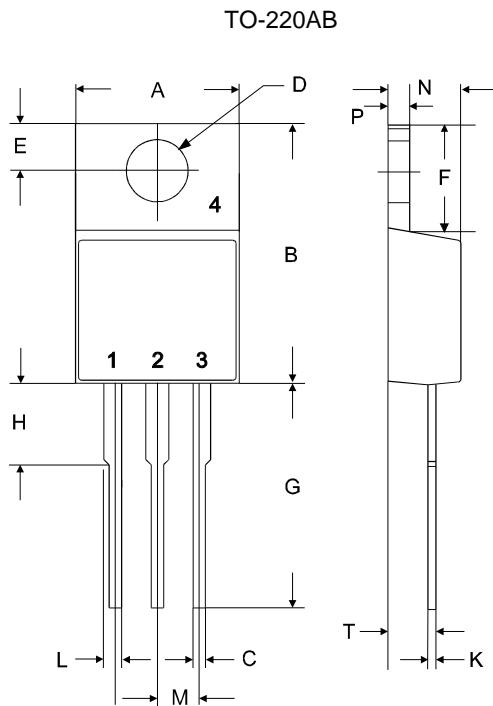
**Figure 18. Typical capacitance as a function of collector-emitter voltage**  
( $V_{GE} = 0V, f = 1MHz$ )



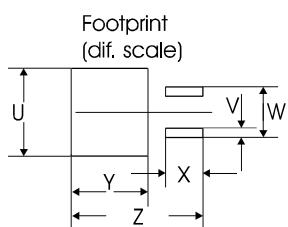
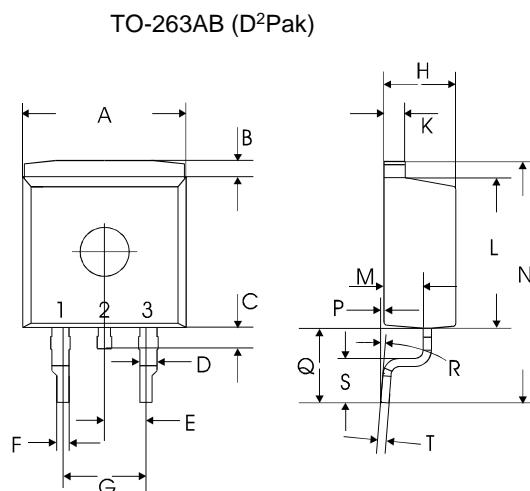
**Figure 19. Short circuit withstand time as a function of gate-emitter voltage**  
( $V_{CE} = 1200V$ , start at  $T_j = 25^{\circ}C$ )



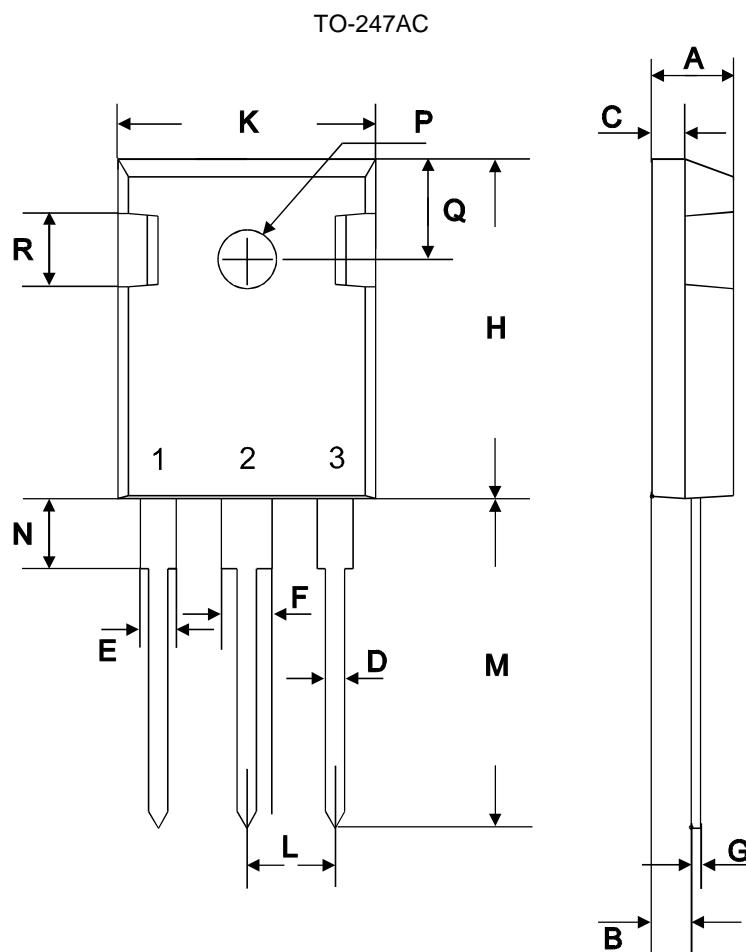
**Figure 20. Typical short circuit collector current as a function of gate-emitter voltage**  
( $100V \leq V_{CE} \leq 1200V, T_C = 25^{\circ}C, T_j \leq 150^{\circ}C$ )



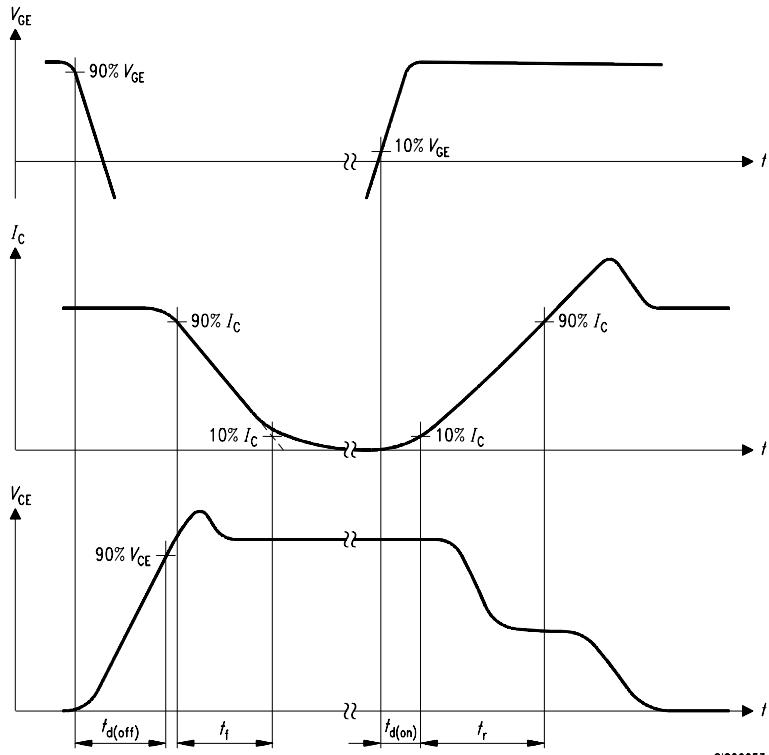
| symbol | dimensions |       |          |        |
|--------|------------|-------|----------|--------|
|        | [mm]       |       | [inch]   |        |
|        | min        | max   | min      | max    |
| A      | 9.70       | 10.30 | 0.3819   | 0.4055 |
| B      | 14.88      | 15.95 | 0.5858   | 0.6280 |
| C      | 0.65       | 0.86  | 0.0256   | 0.0339 |
| D      | 3.55       | 3.89  | 0.1398   | 0.1531 |
| E      | 2.60       | 3.00  | 0.1024   | 0.1181 |
| F      | 6.00       | 6.80  | 0.2362   | 0.2677 |
| G      | 13.00      | 14.00 | 0.5118   | 0.5512 |
| H      | 4.35       | 4.75  | 0.1713   | 0.1870 |
| K      | 0.38       | 0.65  | 0.0150   | 0.0256 |
| L      | 0.95       | 1.32  | 0.0374   | 0.0520 |
| M      | 2.54 typ.  |       | 0.1 typ. |        |
| N      | 4.30       | 4.50  | 0.1693   | 0.1772 |
| P      | 1.17       | 1.40  | 0.0461   | 0.0551 |
| T      | 2.30       | 2.72  | 0.0906   | 0.1071 |



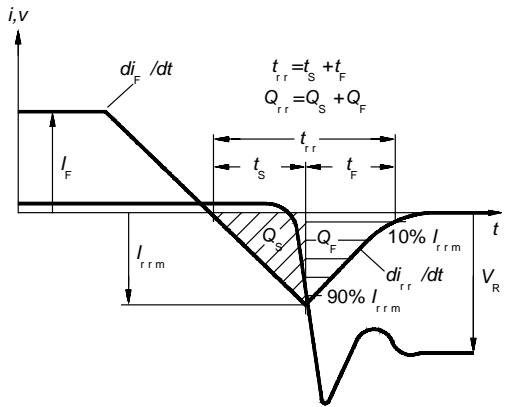
| symbol | dimensions |       |             |        |
|--------|------------|-------|-------------|--------|
|        | [mm]       |       | [inch]      |        |
|        | min        | max   | min         | max    |
| A      | 9.80       | 10.20 | 0.3858      | 0.4016 |
| B      | 0.70       | 1.30  | 0.0276      | 0.0512 |
| C      | 1.00       | 1.60  | 0.0394      | 0.0630 |
| D      | 1.03       | 1.07  | 0.0406      | 0.0421 |
| E      | 2.54 typ.  |       | 0.1 typ.    |        |
| F      | 0.65       | 0.85  | 0.0256      | 0.0335 |
| G      | 5.08 typ.  |       | 0.2 typ.    |        |
| H      | 4.30       | 4.50  | 0.1693      | 0.1772 |
| K      | 1.17       | 1.37  | 0.0461      | 0.0539 |
| L      | 9.05       | 9.45  | 0.3563      | 0.3720 |
| M      | 2.30       | 2.50  | 0.0906      | 0.0984 |
| N      | 15 typ.    |       | 0.5906 typ. |        |
| P      | 0.00       | 0.20  | 0.0000      | 0.0079 |
| Q      | 4.20       | 5.20  | 0.1654      | 0.2047 |
| R      | 8° max     |       | 8° max      |        |
| S      | 2.40       | 3.00  | 0.0945      | 0.1181 |
| T      | 0.40       | 0.60  | 0.0157      | 0.0236 |
| U      | 10.80      |       | 0.4252      |        |
| V      | 1.15       |       | 0.0453      |        |
| W      | 6.23       |       | 0.2453      |        |
| X      | 4.60       |       | 0.1811      |        |
| Y      | 9.40       |       | 0.3701      |        |
| Z      | 16.15      |       | 0.6358      |        |



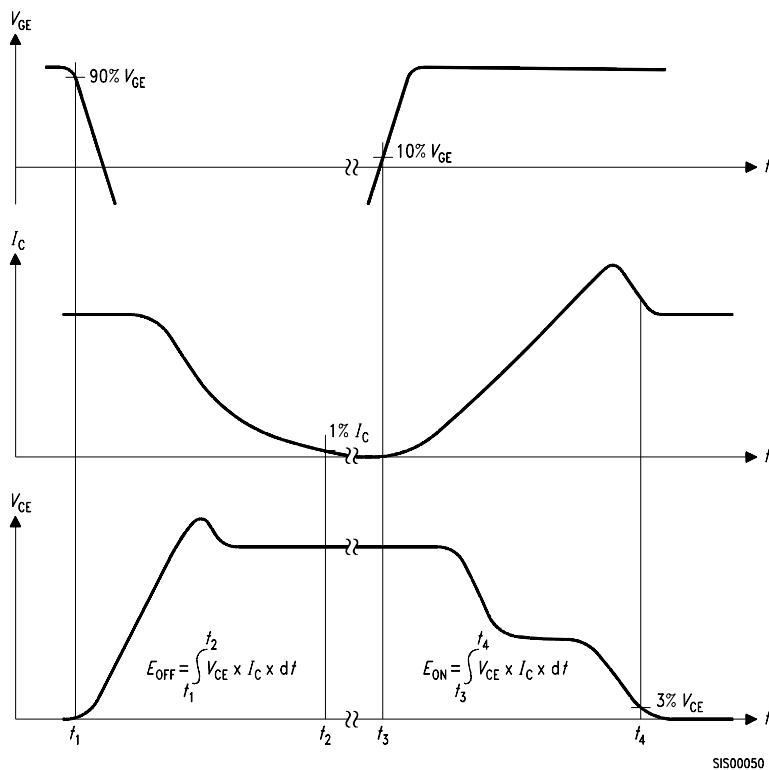
| symbol | dimensions |       |            |        |
|--------|------------|-------|------------|--------|
|        | [mm]       |       | [inch]     |        |
|        | min        | max   | min        | max    |
| A      | 4.78       | 5.28  | 0.1882     | 0.2079 |
| B      | 2.29       | 2.51  | 0.0902     | 0.0988 |
| C      | 1.78       | 2.29  | 0.0701     | 0.0902 |
| D      | 1.09       | 1.32  | 0.0429     | 0.0520 |
| E      | 1.73       | 2.06  | 0.0681     | 0.0811 |
| F      | 2.67       | 3.18  | 0.1051     | 0.1252 |
| G      | 0.76 max   |       | 0.0299 max |        |
| H      | 20.80      | 21.16 | 0.8189     | 0.8331 |
| K      | 15.65      | 16.15 | 0.6161     | 0.6358 |
| L      | 5.21       | 5.72  | 0.2051     | 0.2252 |
| M      | 19.81      | 20.68 | 0.7799     | 0.8142 |
| N      | 3.560      | 4.930 | 0.1402     | 0.1941 |
| ØP     | 3.61       |       | 0.1421     |        |
| Q      | 6.12       | 6.22  | 0.2409     | 0.2449 |



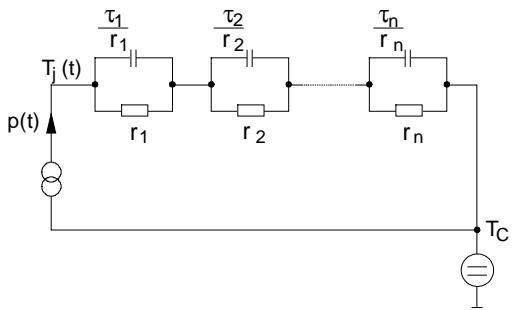
**Figure A. Definition of switching times**



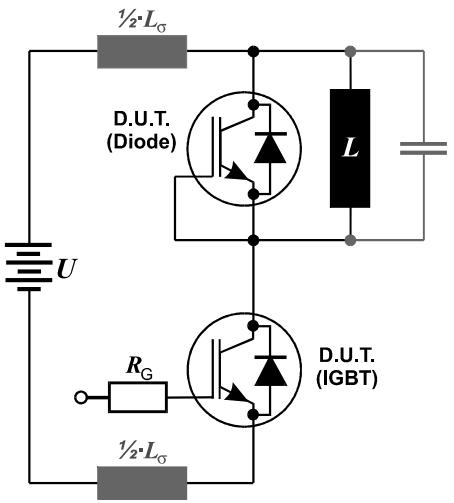
**Figure C. Definition of diodes switching characteristics**



**Figure B. Definition of switching losses**



**Figure D. Thermal equivalent circuit**



**Figure E. Dynamic test circuit**  
Leakage inductance  $L_\sigma=180\text{nH}$ ,  
and stray capacity  $C_\sigma=40\text{pF}$ .



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